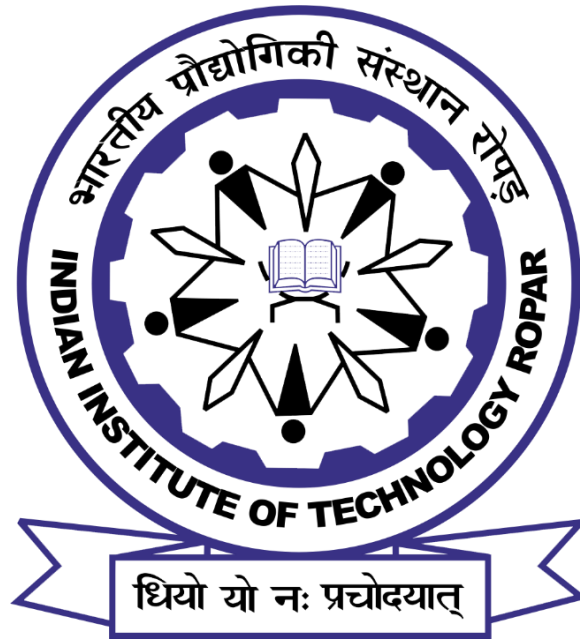


ANALOG CIRCUITS

EE301



Name: A.D.V.M.S.Nikhil

Entry Number: 2022EEB1165

Course Project

AIM:

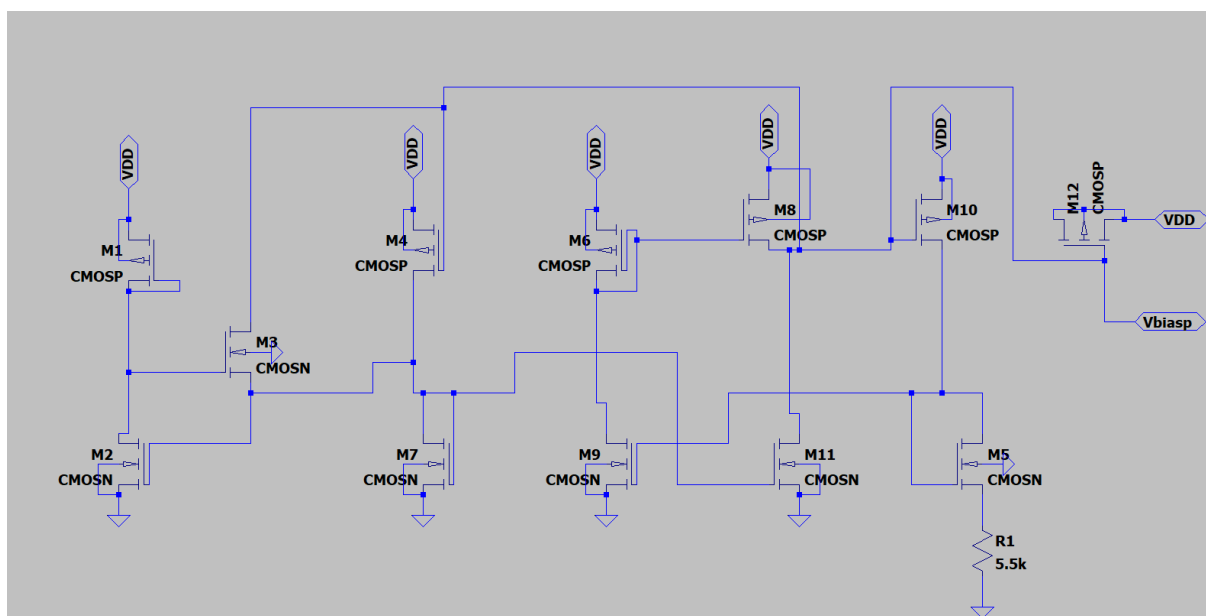
Design of cascode amplifier and cascode current mirror in schematic and layout using LTspice or Cadence and Magic/Cadence tools in 180nm (supply 1.8V) technology and only schematic of cascode amplifier, beta multiplier and cascode current mirror in 22nm (supply 0.8V) technology node to see the effect of lowering the technology node.

LTSpice Simulations:

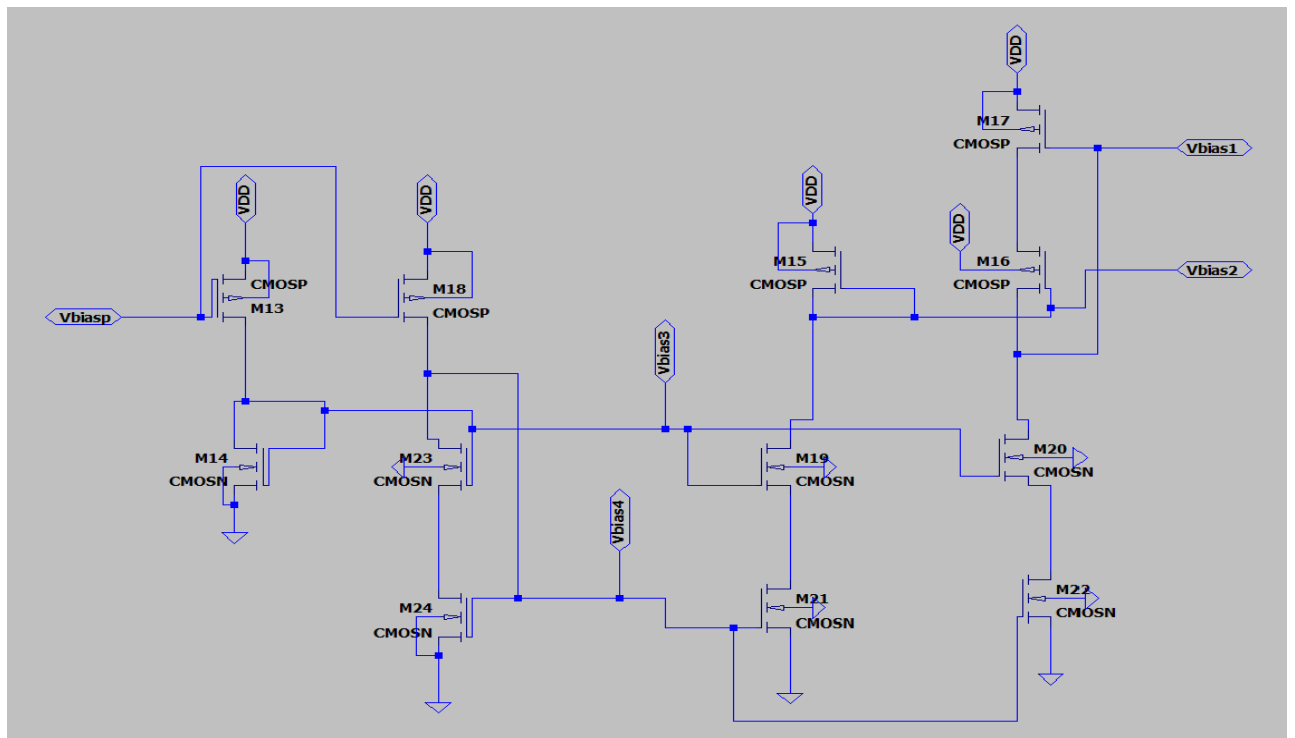
Simulated LTSpice schematics for beta multiplier circuit, cascode current mirror and cascode amplifier for both 180nm and 22nm technology files.

❖ 180nm Technology Simulations

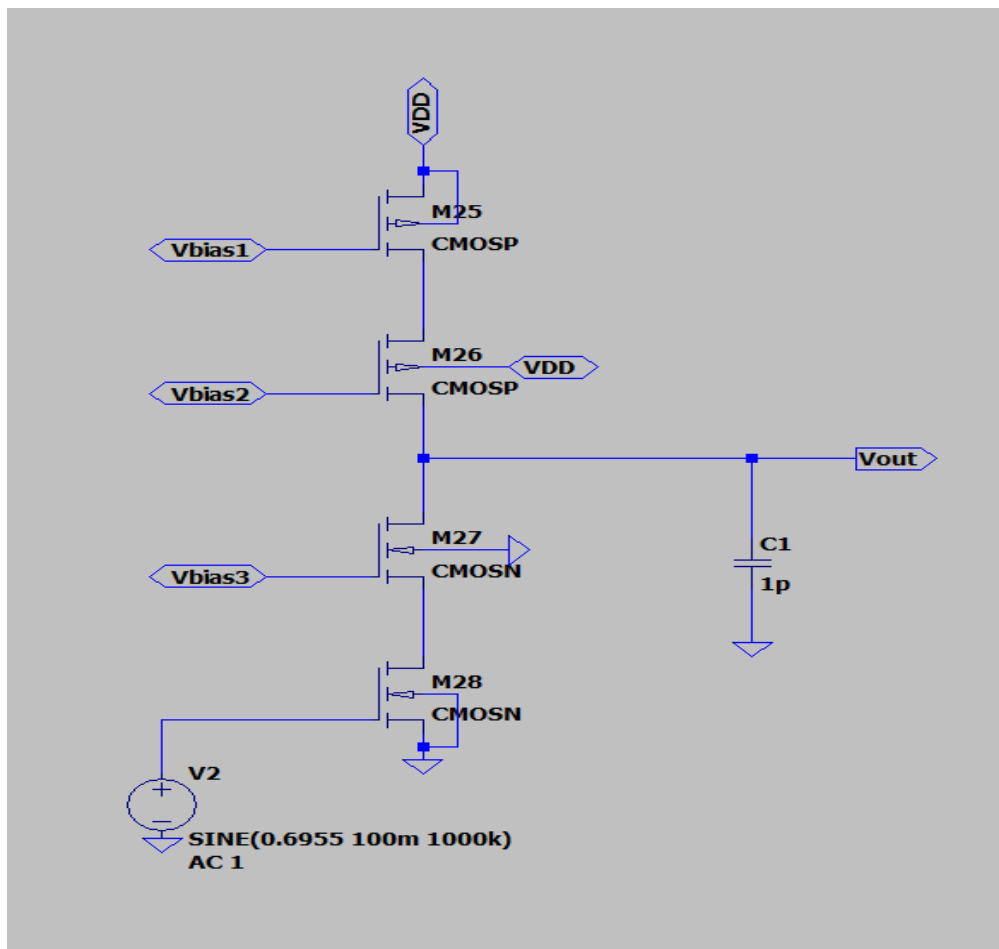
The below LTSpice schematics and respective simulations are set to perform according to the given (W/L) ratios and assigned target specifications for all 3 circuits.



Beta Multiplier Circuit

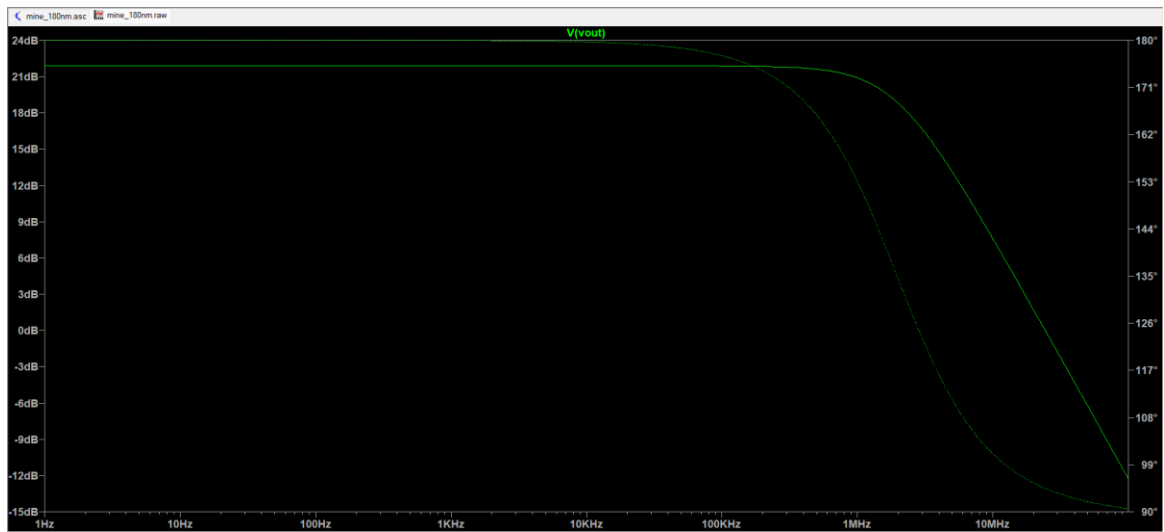


Cascode Current Mirror

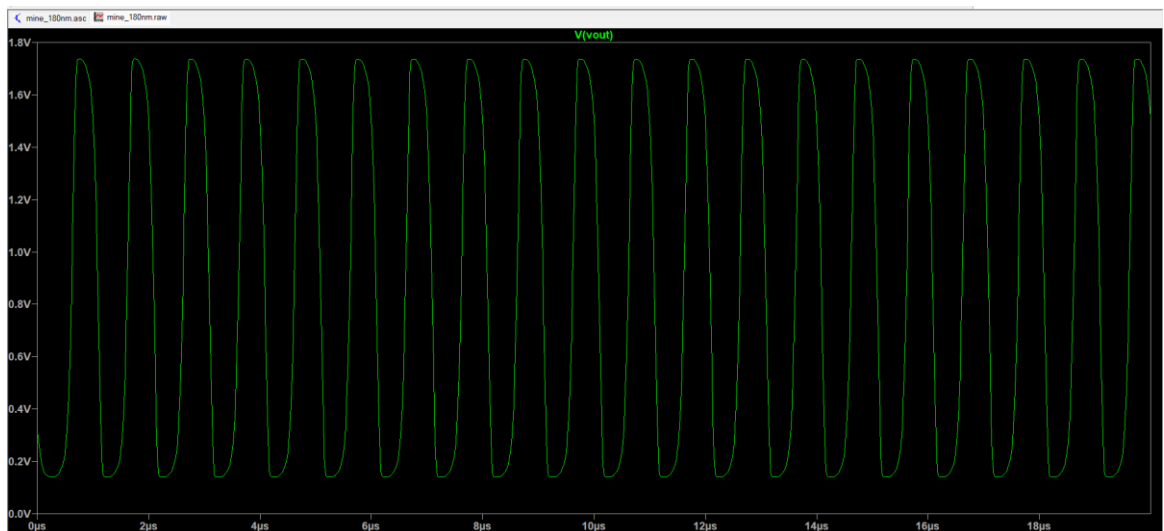


Cascode Amplifier Circuit

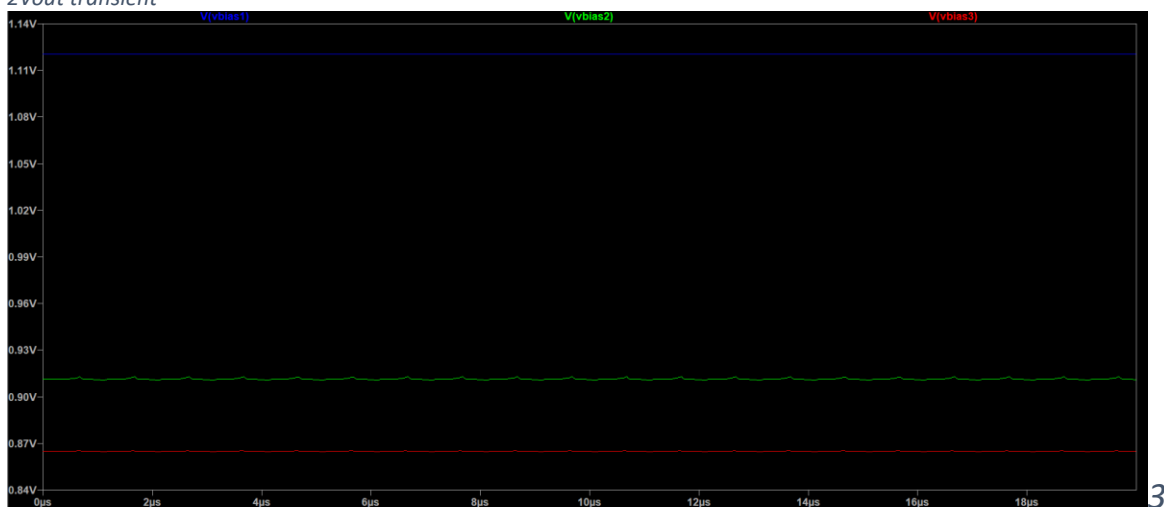
Output Simulations-



1Vout Frequency Plot



2Vout transient



Vbias1, Vbias2, Vbias3 values

180 nm Technology

As per given data, $A_v = 20 \text{ V/V}$ and $C_L = 1 \text{ pF}$ (Capacitive load)
 $V_{DD} = 1.8 \text{ V}$

Frequency of pole (let) = 2.4 MHz

$$R_{out} = \frac{1}{2\pi f C_L} = \frac{1}{2 \times 3.14 \times 2.4 \times 10^6 \times 10^{-12}} = 0.663148 \times 10^6$$

$$\Rightarrow \boxed{R_{out} = 66314.8 \Omega}$$

$$\text{And, } g_m = \frac{A_v}{R_{out}} = \frac{20}{66314.8} = 0.0003015 \text{ S}$$

$$\text{Since, } g_m = \mu_n C_{ox} \left(\frac{W}{L} \right) (V_{as} - V_{th})$$

$$\text{As per given values} \rightarrow \mu_n C_{ox} = 2(175.4) = 350.8 \mu\text{A/V}^2$$

$$\mu_p C_{ox} = 2(35.6) = 71.2 \mu\text{A/V}^2$$

For finding V_{ov} ; we are considering all MOSFETs at the edge of saturation (i.e., $V_{DS} = V_{GS} - V_{th}$)
 $(V_{ov} = V_{DS})$

By taking 0.2 V drop across each MOSFET

For NMOS - $M_4 \rightarrow V_D = 0.2 \text{ V}, V_S = 0$

$$\Rightarrow V_{DS} = 0.2 \text{ V}$$

$$\Rightarrow 0.2 > V_{GS} - V_{th} \quad \{V_{th} = 0.51 \text{ V}\}$$

$$\Rightarrow \boxed{V_{GS} \leq 0.71 \text{ V}}$$

For NMOS - $M_3 \rightarrow V_D = 0.4 \text{ V}, V_S = 0.2 \text{ V}$

$$\Rightarrow 0.2 > V_{bias3} - 0.2 - 0.51$$

$$\Rightarrow \boxed{(V_{bias})_3 \leq 0.91 \text{ V}}$$

$$\Rightarrow g_m = \mu_n C_{ox} \left(\frac{W}{L}\right)_n V_{ov}$$

$$\Rightarrow \left(\frac{W}{L}\right)_n = \frac{(6.0003015)}{(350.8)(0.2)} = 4.2973$$

$$\boxed{\left(\frac{W}{L}\right)_{n_{min}} = 4.2973}$$

$$\Rightarrow I_{D1} = \frac{1}{2} \mu_n C_{ox} (V_{ov})^2 \left(\frac{W}{L}\right)_n (1 + \lambda V_{DS})$$

$$= \frac{1}{2} (350.8) (0.2)^2 (4.2973) (1 + (0.09)(0.2))$$

$$\boxed{I_{D1} = 30.622 \mu\text{A}}$$

$$\Rightarrow I_D = \frac{1}{2} \mu_p C_{ox} \left(\frac{W}{L}\right)_p V_{ov}^2 (1 + \lambda V_{DS})$$

$$\left(\frac{W}{L}\right)_p = \frac{30.622 \times 10^{-6}}{(0.5)(71.2 \times 10^{-6})(0.2)^2 (1 + (0.09)(0.2))}$$

$$\boxed{\left(\frac{W}{L}\right)_p = 21.1864}$$

for PMOS-M₂

$$V_{SD} \geq V_{SG} - V_{th,p}$$

$$0.8 \geq 1.6 - V_{bias2} - 0.5$$

$$\Rightarrow V_{bias2} \geq 0.87 \text{ V}$$

$$V_S = 1.6 \text{ V} \mid V_D = 1.4 \text{ V}$$

for PMOS-M₁

$$\Rightarrow 0.8 \geq 1.8 - V_{bias1} - 0.5$$

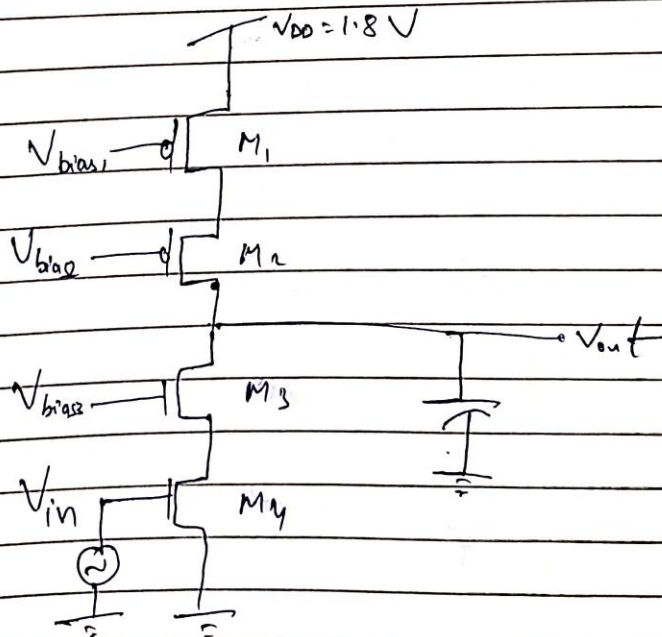
$$\Rightarrow V_{bias1} \geq 1.09 \text{ V}$$

$$V_S = 1.8 \text{ V} \mid V_D = 1.6 \text{ V}$$

$$\rightarrow \text{Power Dissipation (PD)} = V_{DD} \cdot I_d$$

$$= (1.8)(30.66)$$

$$PD = 0.0551 \text{ mW}$$

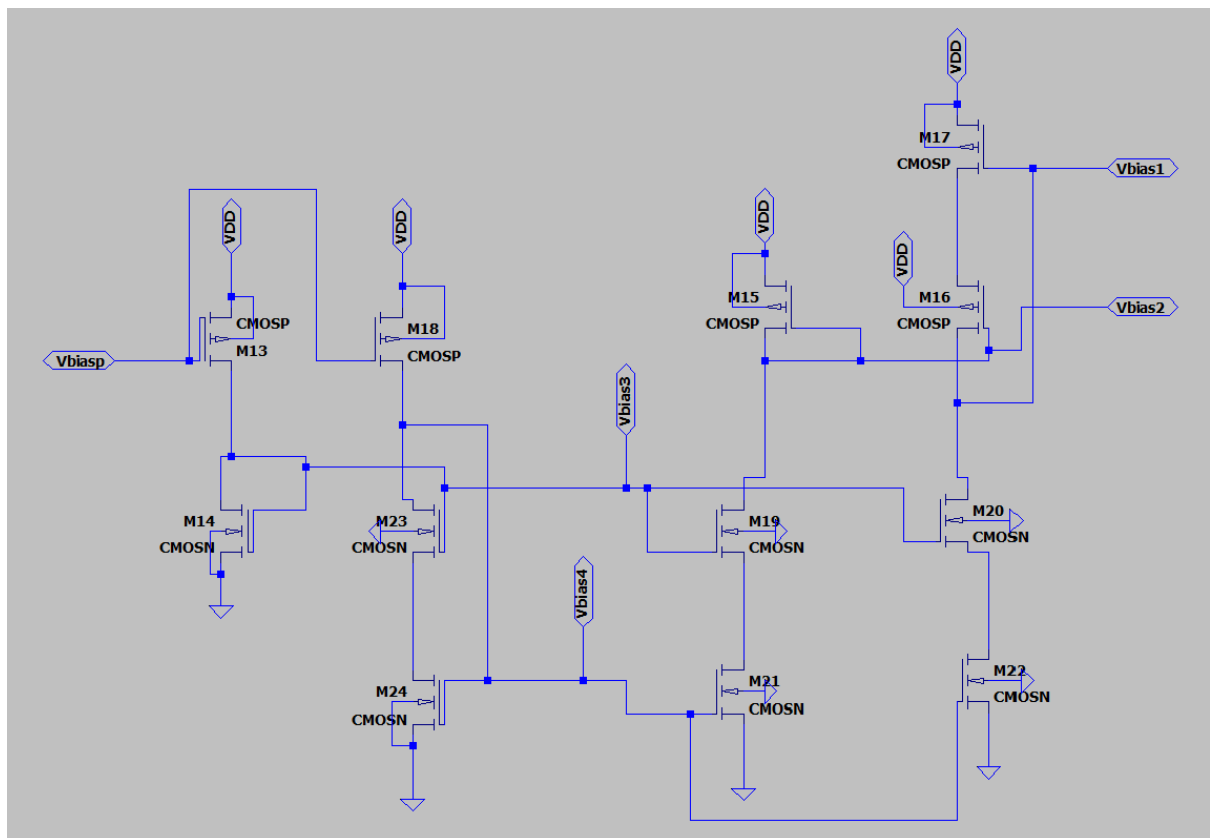
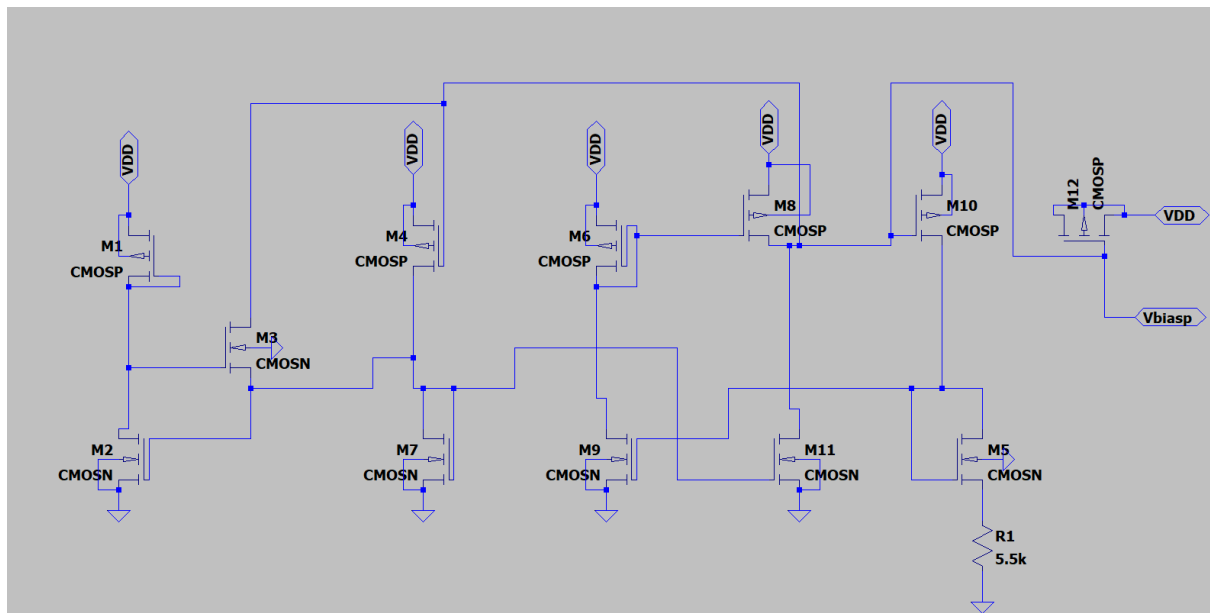


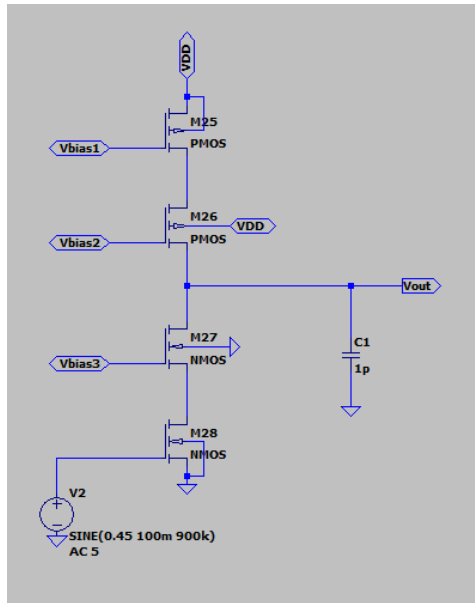
Comparing theoretical and simulated values

<u>Theoretical v/s Simulated Results (180nm)</u>		
	<u>Theoretical Values</u>	<u>Simulated Results</u>
A_v $= 20 V/V$	$20 \log_{10} 20 = 26.06 \text{ dB}$	21.89 dB
V_{GB}	$> 500 \text{ kHz}$	2500.85 MHz
I_D	30.622 μA	27.65 μA
Power Dissipation	$< 5 \text{ mW}$ {0.0551 mW}	$27.65 \mu \times 1.8 \text{ V}$ $= 0.04977 \text{ mW}$
V_{biasp}	-	1.223 V
V_{bias1}	$\geq 1.09 \text{ V}$	1.12 V
V_{bias2}	$\geq 0.8 \text{ V}$	0.91 V
V_{bias3}	$\leq 0.91 \text{ V}$	0.865 V

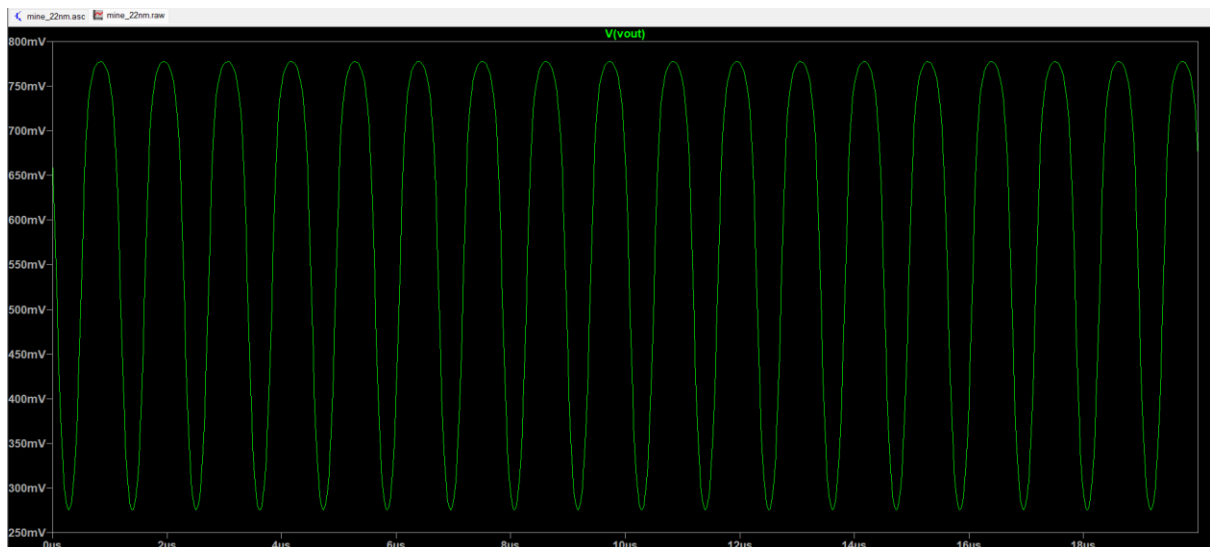
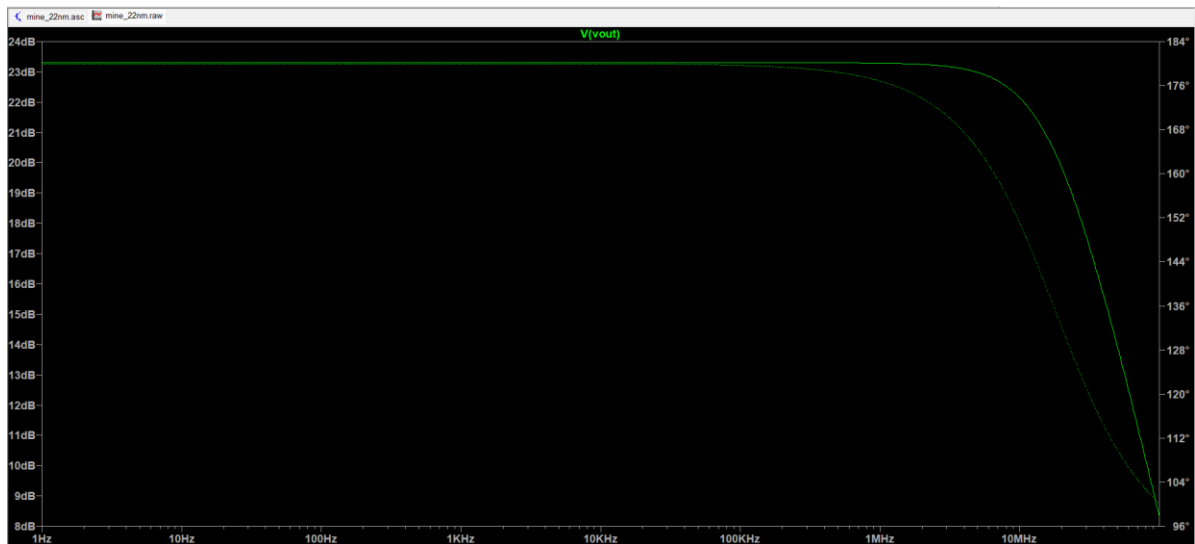
❖ 22nm Technology Simulations

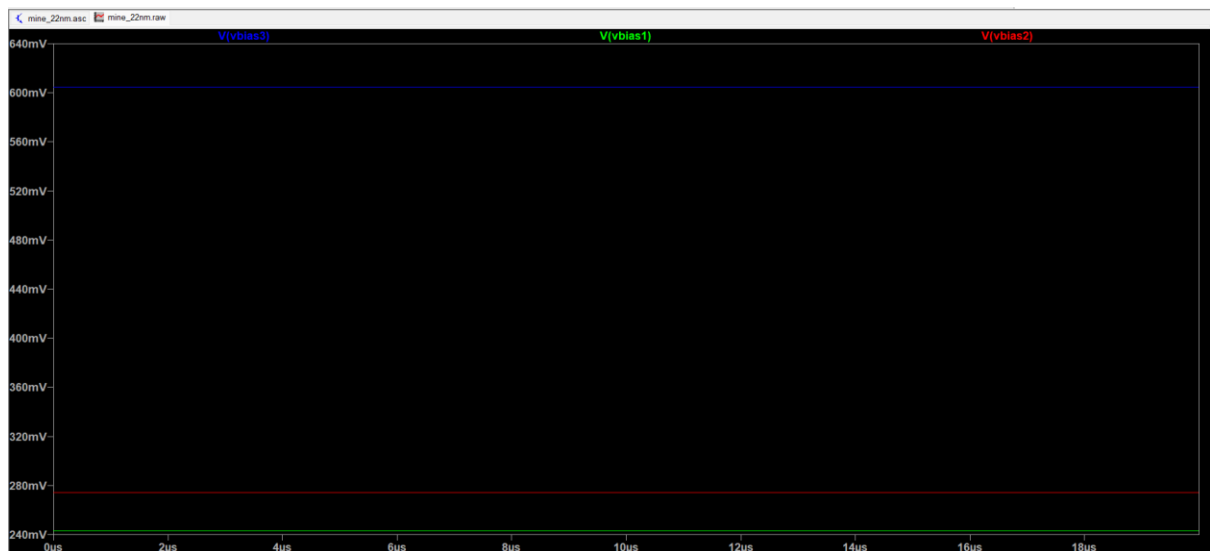
The below LTSpice schematics and respective simulations are set to perform according to the given (W/L) ratios and assigned target specifications for all 3 circuits.





Output Simulations





Calculations for designing the cascode amplifier for target specifications (180nm tech)

As per given data $A_v = 20 \text{ V/V}$ and $C_L = 1 \text{ pF}$ (capacitive load), $V_{DD} = 0.8 \text{ V}$
 $V_{th} = 0.3 \text{ V}$
 $V_{ov} = 0.2 \text{ V}$

Frequency of pole (let) $= 2.7 \text{ MHz}$

$$R_{out} = \frac{1}{2\pi f C_L} = \frac{1}{2\pi \times 2.7 \times 10^6 \times 10^{-12}} = 58946.27 \Omega //$$

$$\text{And, } g_m = \frac{A_v}{R_{out}} = \frac{20}{58946.27} = 0.0003392 \text{ S} //$$

$$\text{Since, } g_m = \mu_n C_{ox} \left(\frac{W}{L}\right) (V_{GS} - V_{th})$$

As per given values $\rightarrow \mu_n C_{ox} = 100 \mu\text{A/V}^2$
 $\mu_p C_{ox} = 50 \mu\text{A/V}^2$

$$\Rightarrow \left(\frac{W}{L}\right)_n = \frac{0.0003392}{(0.2)(100 \times 10^{-6})} = 16.964 //$$

$$\text{And, } I_D = \frac{1}{2} \mu_n C_{ox} (V_{ov})^2 \left(\frac{W}{L}\right)_n$$

$$= \frac{1}{2} (100 \times 10^{-6}) (0.04)^2 \times (16.964)$$

$$\Rightarrow I_D = \frac{1}{2} \mu_p C_{ox} V_{ov} \left(\frac{W}{L}\right)_p = 33.928 \mu\text{A}$$

$$\Rightarrow \left(\frac{W}{L}\right)_p = \frac{33.928 \times 10^{-6}}{(1/2)(50 \times 10^{-6})(0.04)} = 33.928 //$$

$$\rightarrow \text{Power Dissipation (PD)} = V_{DD} \times I_D$$

$$= (0.8)(33.728 \mu)$$

$$\boxed{PD = 27.1424 \mu W}$$

$$\Rightarrow PD = 0.097 \text{ mW}$$

$$\left(\frac{W}{L}\right)_n = 16.964$$

$$\left(\frac{W}{L}\right)_p = 33.728$$

\rightarrow For NMOS - M₄ { operating
in saturation region }

$$\Rightarrow 0.2 \geq V_{GS} - V_{th}$$

$$\Rightarrow \boxed{V_{in} \leq 0.5V}$$

$$V_S = 0$$

$$V_{DS} = 0.2V$$

$$V_G = V_{in}$$

\rightarrow For NMOS - M₃

$$V_{DS} \geq V_{GS} - V_{th}$$

$$\Rightarrow 0.2 \geq V_{bias3} - 0.2 - 0.3$$

$$\Rightarrow \boxed{V_{bias3} \leq 0.7V}$$

$$V_D = 0.4V$$

$$V_S = 0.8V$$

\rightarrow For PMOS - M₂

$$V_{SD} \geq V_{SG} - V_{thp}$$

$$0.2 \geq 0.6 - V_{bias2} - 0.3$$

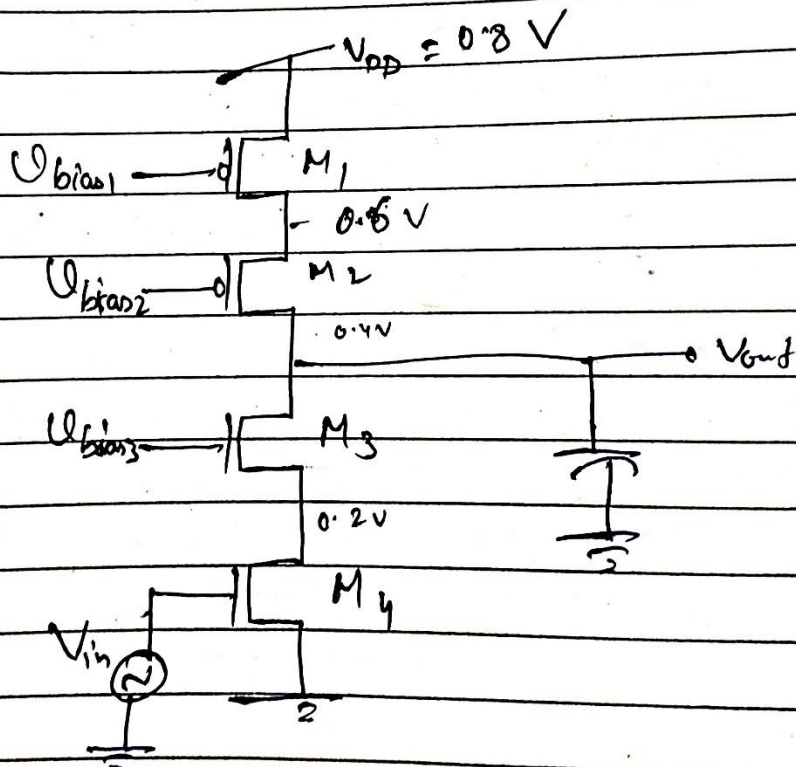
$$\Rightarrow \boxed{V_{bias2} \geq 0.1V}$$

→ For PMOS - M_1

$$V_{SD} \geq V_{SG} - V_{thp}$$

$$\Rightarrow 0.2 \geq 0.8 - V_{bias1} - 0.3$$

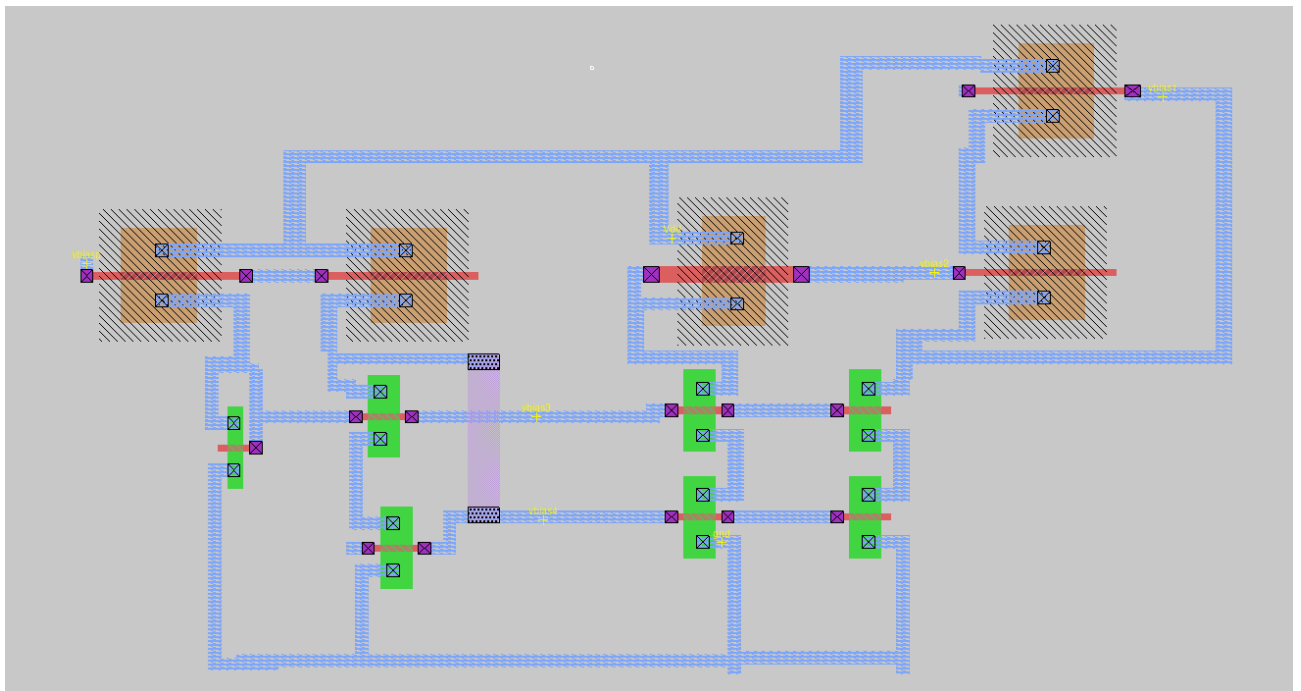
$$\Rightarrow \boxed{V_{bias1} \geq 0.3V}$$



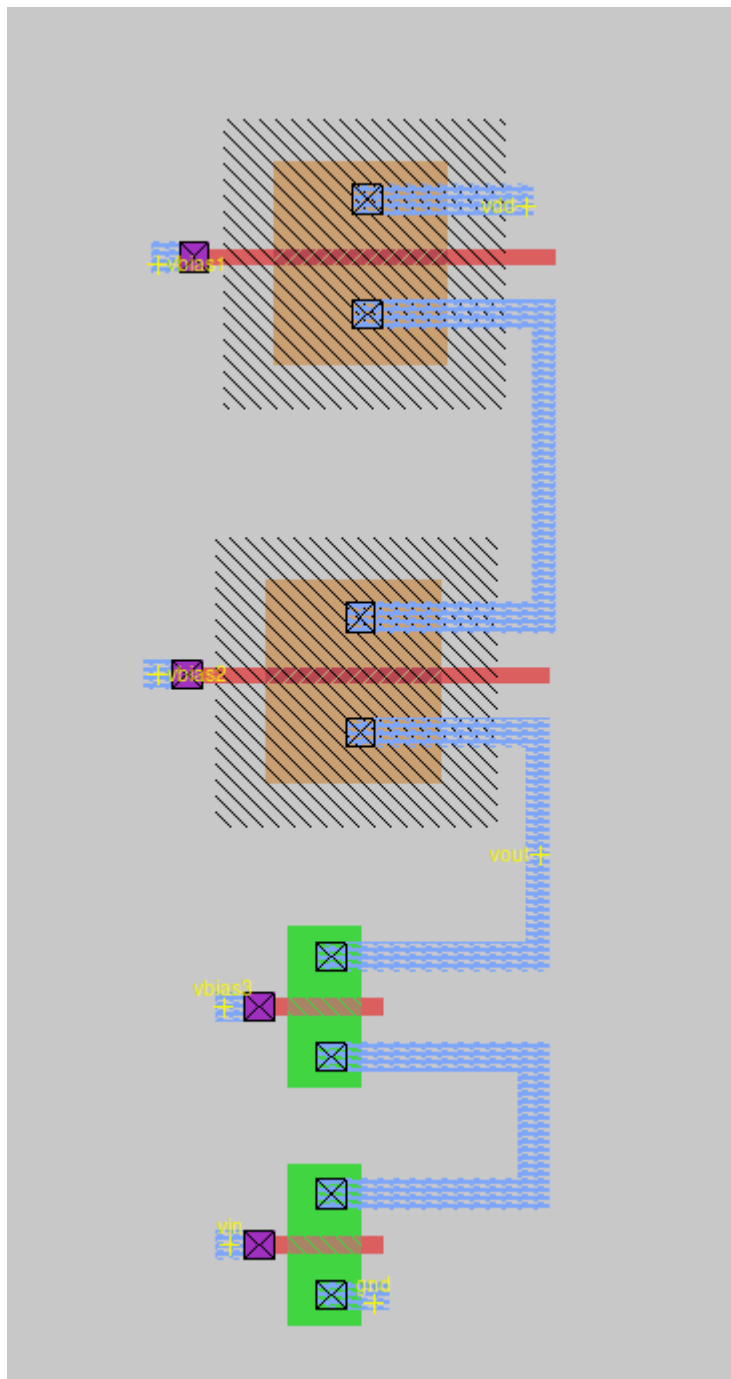
Theoretical v/s Simulated Results (22nm)

	Theoretical Values	Simulated Results
$A_v (20V/V)$	$20 \log_{10} 20 = 26.06 \text{ dB}$	20.20 dB 23.30 dB
U_{GB}	$> 300 \text{ kHz}$	275 MHz
Power Dissipation	$< 5 \text{ mW}$ {0.027 mW}	0.02396 mW
I_D	33.92 μA	27.75 μA
U_{biasP}	-	248.48 mV
U_{bias1}	$> 0.3 \text{ V}$	243.08 mV
U_{bias2}	$> 0.1 \text{ V}$	274.5 mV
U_{bias3}	$\leq 0.7 \text{ V}$	604.538 mV

MAGIC LAYOUTS



Current Mirror Circuit Layout



Cascode Amplifier Circuit

Comparison between 180nm and 22nm Technology:

- **Compact Design:** The smaller size of 22nm transistors (roughly 8 times smaller than 180nm transistors) allows for more components on a chip, improving overall performance and efficiency.
- **Manufacturing Complexity:** With the smaller size of 22nm transistors, layouts are more challenging to design, which may result in higher manufacturing costs.
- **Power Efficiency:** 22nm technology requires lower bias voltages and currents, leading to lower power consumption compared to 180nm technology. This makes it a more energy-efficient option for applications requiring low power usage.
- **Heat Dissipation:** Due to reduced power consumption, 22nm technology can contribute to lower heat generation, which helps in maintaining device longevity and performance stability.
- **Higher Frequency Response:** 22nm technology provides a higher Unity Gain Bandwidth, resulting in a higher cut-off frequency. This allows devices to operate at higher speeds and with improved frequency performance.
- **Potential for Increased Density:** 22nm technology can lead to higher density of transistors on a chip, allowing for more functionality and complex designs in a smaller physical space.

Conclusion:

We simulated various components (Beta Multiplier, Cascode Current Mirror, and Cascode Amplifier) on both 180nm and 22nm technology using LTSpice. The simulation results are same as theoretical values and met performance requirements. Additionally, we designed layouts for Cascode Current Mirror and Cascode Amplifier using Magic software for the 180nm technology. This allowed us to compare 180nm and 22nm technology based on LTSpice simulations and layout design in Magic.